Notice of References Cited Application/Control No. 10/604,790 Examiner Cheukfan Lee Applicant(s)/Patent Under Reexamination KUAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,104,510	08-2000	Hu et al.	358/509	
	В	US-				
	C	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
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	К	US-				
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	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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